

IRFU224BTU-VB Datasheet

Power MOSFET

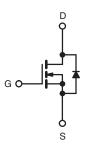
PRODUCT SUMMARY					
V _{DS} (V)	250				
R _{DS(on)} (Ω)	V _{GS} = 10 V 1.1				
Q _g (Max.) (nC)	14				
Q _{gs} (nC)	2.7				
Q _{gd} (nC)	7.8				
Configuration	Single				

FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Available in Tape and Reel
- Fast Switching
- Ease of Paralleling







N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (To	, 20 0, 4111000 011101 1111				
PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage	V_{DS}	250	V		
Gate-Source Voltage		V_{GS}	± 20	V	
Continuous Drain Current	V_{GS} at 10 V $T_{C} = 25 ^{\circ}C$ $T_{C} = 100 ^{\circ}C$	I_	3.8		
Continuous Drain Current	$T_C = 100 ^{\circ}$ C	l _D	2.4	Α	
Pulsed Drain Current ^a	I _{DM}	15			
Linear Derating Factor		0.33	W/°C		
Linear Derating Factor (PCB Mount)e		0.020			
Single Pulse Avalanche Energy ^b	E _{AS}	130	mJ		
Repetitive Avalanche Current ^a	I _{AR}	3.8	Α		
Repetitive Avalanche Energy ^a	E _{AR}	4.2	mJ		
Maximum Power Dissipation	T _C = 25 °C	Б	42	W	
Maximum Power Dissipation (PCB Mount) ^e	T _A = 25 °C	P_D	2.5] vv	
Peak Diode Recovery dV/dtc	dV/dt	4.8	V/ns		
Operating Junction and Storage Temperature Ran	T _J , T _{sta} - 55 to + 150	00			
Soldering Recommendations (Peak Temperature)d		260	°C		

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $V_{DD} = 50 \text{ V}$; starting $T_J = 25 \text{ °C}$, L = 14 mH, $R_g = 25 \Omega$, $I_{AS} = 3.8 \text{ A}$ (see fig. 12). c. $I_{SD} \le 3.8 \text{ A}$, $dI/dt \le 90 \text{ A/µs}$, $V_{DD} \le V_{DS}$, $T_J \le 150 \text{ °C}$.
- d. 1.6 mm from case.
- e. When mounted on 1" square PCB (FR-4 or G-10 material) .



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient (PCB Mount) ^a	R _{thJA}	-	50		
Maximum Junction-to-Ambient	R _{thJA}	-	110	°C/W	
Maximum Junction-to-Case	R _{thJC}	-	3.0		

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static						l	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		250	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	ce to 25 °C, I _D = 1 mA	-	0.36	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 20 V	-	-	± 100	nA
Zana Oala Wallana Baria Oamad		V _{DS} =	V _{DS} = 250 V, V _{GS} = 0 V		-	25	_
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 200 V	/, V _{GS} = 0 V, T _J = 125 °C	-	-	250	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 2.3 A ^b	-	1.1	-	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	= 50 V, I _D = 2.3 A ^b	1.5	-	-	S
Dynamic							
Input Capacitance	C _{iss}		V _{GS} = 0 V,	-	260	-	pF
Output Capacitance	Coss	1	$V_{DS} = 25 \text{ V},$	-	77	-	
Reverse Transfer Capacitance	C _{rss}	f = 1.	0 MHz, see fig. 5 ^c	-	15	-	
Total Gate Charge	Qg				-	14	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$I_D = 4.4 \text{ A}, V_{DS} = 200 \text{ V},$ see fig. 6 and 13 ^{b, c}	-	-	2.7	nC
Gate-Drain Charge	Q _{gd}	1	ooo ng. o ana ro	-	-	7.8	
Turn-On Delay Time	t _{d(on)}			-	7.0	-	
Rise Time	t _r	V_{DD} = 125 V, I_{D} = 4.4 A, R_{G} = 18 Ω , R_{D} = 28 Ω , see fig. 10 ^{b, c}		-	13	-	ns
Turn-Off Delay Time	t _{d(off)}			-	20	-	
Fall Time	t _f			-	12	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from		-	4.5	-	-11
Internal Source Inductance	L _S	package and die contact	package and center of die contact		7.5	-	- nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the		-	-	3.8	Α
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	15	
Body Diode Voltage	V_{SD}	T _J = 25 °C, I _S = 3.8 A, V _{GS} = 0 V ^b		-	-	1.8	V
Body Diode Reverse Recovery Time	t _{rr}	T. = 25 °C I	- 4.4 A dl/dt - 100 A/wah	-	200	400	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$-$ T _J = 25 °C, I _F = 4.4 A, dI/dt = 100 A/ μ s ^b		-	0.93	1.9	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D)					L _D)

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

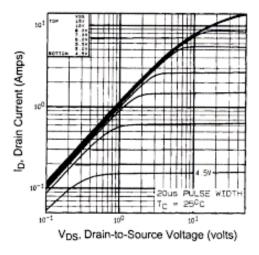


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

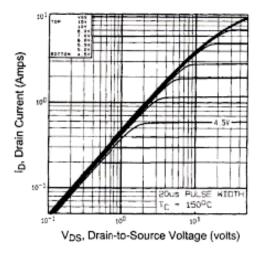


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

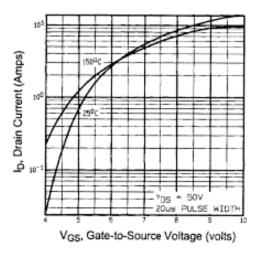


Fig. 3 - Typical Transfer Characteristics

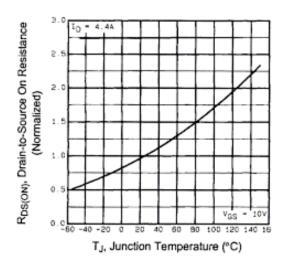


Fig. 4 - Normalized On-Resistance vs. Temperature



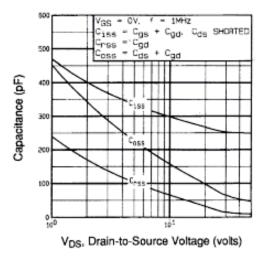


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

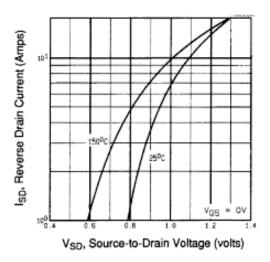


Fig. 7 - Typical Source-Drain Diode Forward Voltage

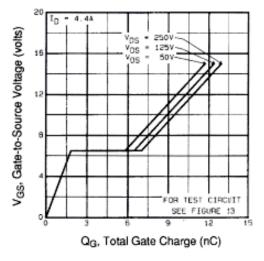


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

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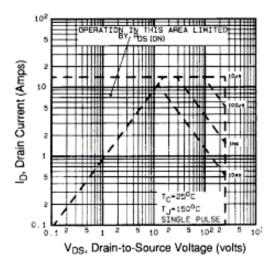


Fig. 8 - Maximum Safe Operating Area



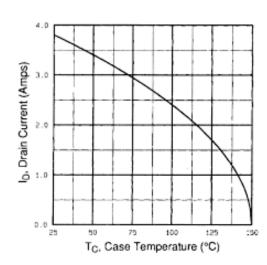


Fig. 9 - Maximum Drain Current vs. Case Temperature

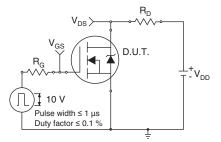


Fig. 10a - Switching Time Test Circuit

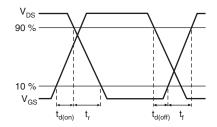
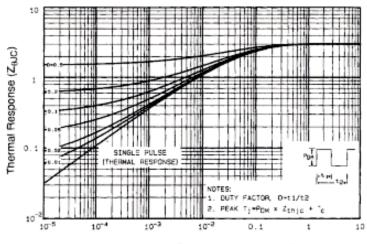


Fig. 10b - Switching Time Waveforms



t₁, Rectangular Pulse Duration (seconds)

Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



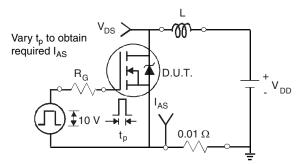


Fig. 12a - Unclamped Inductive Test Circuit

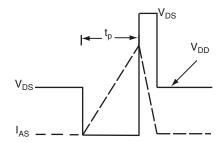


Fig. 12b - Unclamped Inductive Waveforms

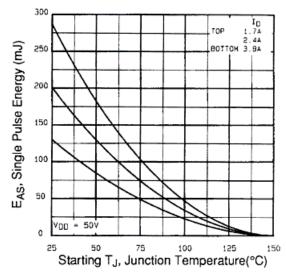


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

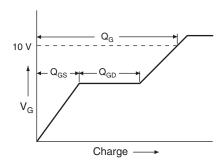


Fig. 13a - Basic Gate Charge Waveform

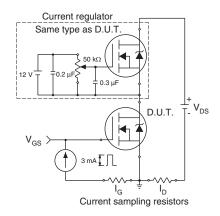
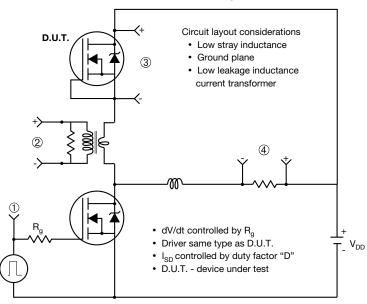


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



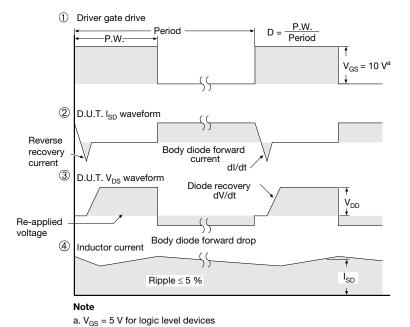
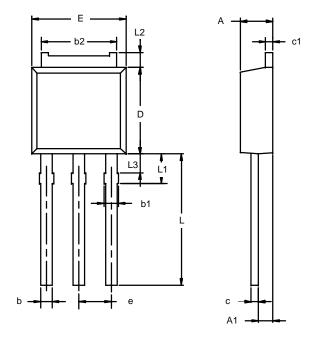


Fig. 14 - For N-Channel



TO-251AA



Note:	Dimension	L3 is for	reference	only.
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	MILLIN	IETERS	INC	HES
Dim	Min	Max	Min	Max
Α	2.21	2.38	0.087	0.094
A1	0.89	1.14	0.035	0.045
b	0.71	0.89	0.028	0.035
b1	0.76	1.14	0.030	0.045
b2	5.23	5.43	0.206	0.214
С	0.46	0.58	0.018	0.023
c1	0.46	0.58	0.018	0.023
D	5.97	6.22	0.235	0.245
E	6.48	6.73	0.255	0.265
е	2.28	2.28 BSC		BSC
L	3.89	9.53	0.153	0.375
L1	1.91	2.28	0.075	0.090
L2	0.89	1.27	0.035	0.050
L3	1.15	1.52	0.045	0.060



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